

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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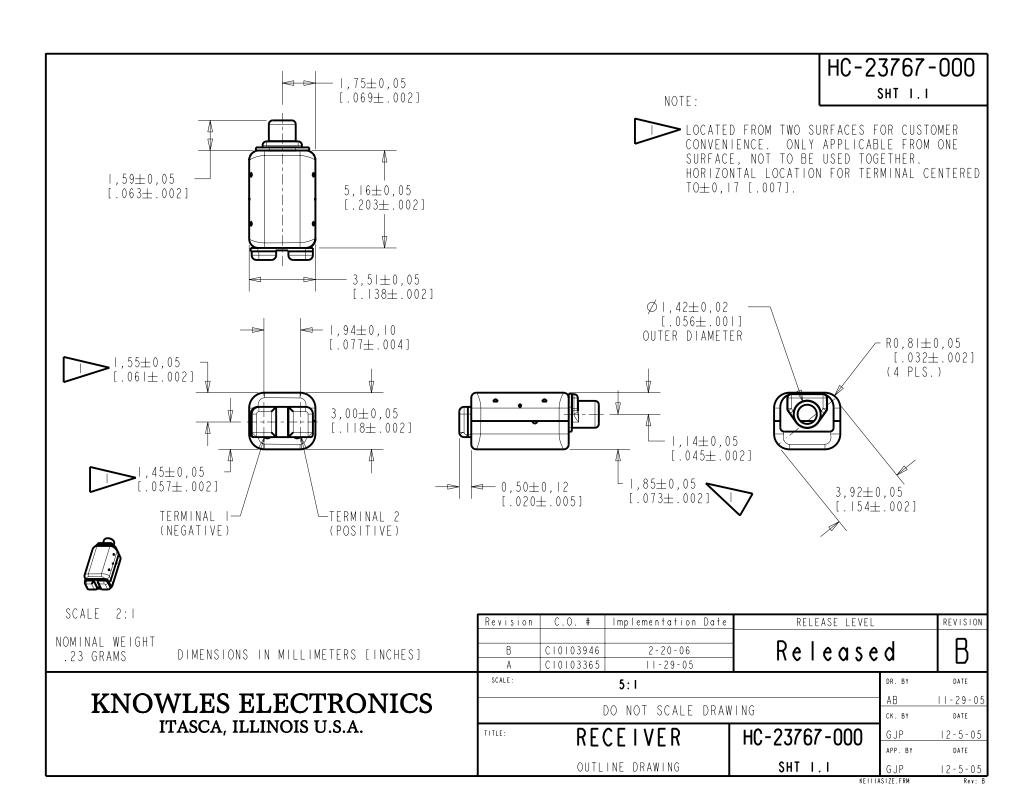
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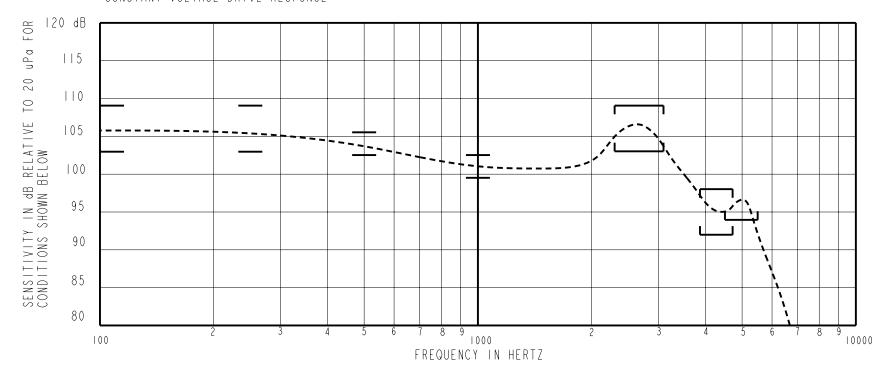
## HC-23767-000 SHEET 2.1

#### DESCRIPTION

THE HC-23767-000 IS A MAGNETIC BALANCED ARMATURE RECEIVER INTENDED FOR USE IN ITC AND CIC HEARING INSTRUMENTS. THE HC FAMILY OFFERS 6 dB HIGHER OUTPUT LEVELS IN THE SAME SIZE PACKAGE AS THE FC FAMILY. ALL HC UNITS HAVE SHOCK PROTECTION. THIS MODEL HAS LOW IMPEDANCE AND IS UNDAMPED.

NOTE: SPECIFICATIONS FOLLOWED BY AN ASTERISK (\*) ARE 100% TESTED.

#### CONSTANT VOLTAGE DRIVE RESPONSE



#### ACOUSTICAL

#### SENSITIVITY\*

DEVICE WILL PRODUCE THE SPL LISTED BELOW WUTH THE TEST CONDITIONS DESCRIBED IN TABLES 3. NOMINAL SENSITIVITY AT I kHz IS dB RELATIVE TO 20uPa. ALL OTHER VALUES IN dB RELATIVE TO THE SENSITIVITY AT 1 kHz.

FREQUENCY (Hz)	MINIMUM	NOMINAL	MAXIMUM
100	+ 2	+ 5	+8
250	+ 2	+ 5	+8
500	1.5	+ 3	+4.5
1000	-1.5	101.0	+1.5
2300-3100 PEAK	+ 2	+ 5	+8
3890-4750 VALLEY	- 9	- 6	- 3
4500-5500 PEAK	- 7		

TABLE I.

### TOTAL HARMONIC DISTORTION\*

DEVICE WILL NOT EXCEED TOTAL HARMONIC DISTORTION LEVELS LISTED BELOW.

FREQUENCY (Hz)	DRIVE (V RMS)	DC BIAS (MA)	LIMIT (%)
900	.169 V	0	5
1350	.169 V	0	5
500	.475 V	0	Ι 0

TABLE 2.

#### TEST CONDITIONS

NOMINAL SOURCE VOLTAGE	.169 Vrms, O Vdc BIAS
SOURCE IMPEDANCE	< Ι Ω
TUBING	10 mm (.394) LONG,   mm (.039)   D.
COUPLER CAVITY	2 CC SIMULATED ANSI S3.7 TYPE HA-3, (IEC 126)

TABLE 3.

#### POLARITY \*

POSITIVE SIGNAL APPLIED TO TERMINAL 2 WILL PRODUCE A DECREASE IN SOUND PRESSURE AT THE SOUND OUTLET.

#### ELECTRICAL

DC RESISTANCE	44Ω ±10%	*
IMPEDANCE @ 500 Hz	67Ω ±15%	*
IMPEDANCE @ I kHz	117Ω ±20%	*
INDUCTANCE @ 500Hz	16mH ±15%	
CAPACITANCE @ 10 MHz	6pF ±20%	

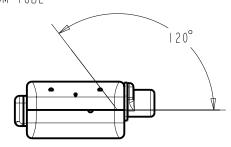
TABLE 4.

ISOLATION: THE CASE WILL BE ELECTRICALLY ISOLATED FROM THE COIL CIRCUIT\*

### MAGNETIC RADIATION

WORST CASE: FIELD WILL BE LESS THAN LEVEL STATED BELOW AT AMPLIFIER CLIPPING (.920 V).

134 dB re lμA/m DISTANCE OF 6.3 mm FROM CENTER OF RECEIVER ANGLE OF 120 DEGREES FROM TUBE



### MECHANICAL

PORT LOCATION: 12C

SOLDER TYPE: 96.5% Sn, 3% Ag, 0.5% Cu (LEAD FREE)

TEMPERATURE

OPERATING: SENSITIVITY WILL NOT VARY MORE THAN

+1/-3 dB FROM -17°C TO 63°C

STORAGE: -40°C TO 63°C

## RELIABILITY

TITLE:

UNITS WILL SURVIVE ANY OF THE FOLLOWING ACCELERATED LIFE TESTS, REPORT AVAILABLE FROM QA DEPARTMENT

HALT TEST (8 WEEKS, 63°C, 95% RH, 0.83V, 500 Hz SIGNAL) HIGH TEMPERATURE STORAGE (63°C, 72 HOURS) LOW TEMPERATURE STORAGE (-40°C, 72 HOURS)
DAMP HEAT CYCLING (ALTERNATE 25°C TO 63°C, 93% RH, 20 CYCLES) THERMAL SHOCK (-40°C TO 63°C, 5 CYCLES) SOLDER/DESOLDER CYCLING (5 CYCLES) SOLDER PAD STRENGTH (STRENGTH > 1.8 LBS.) STRESS TEST (3.14 Vrms AT 2700 Hz SIGNAL, I HOUR)

MECHANICAL SHOCK

LEAK TEST AFTER AGING (NO LEAK AFTER ANY OF THE ABOVE TESTS)

Revision	C.O. #	Implementation Date	RELEASE LEVEL	REVISION
			6	ר
В	C10103946	2 - 20 - 06	l Released I	H
Α	C10103365	11-29-05		

# **KNOWLES ELECTRONICS** ITASCA, ILLINOIS U.S.A.

WHEN T	EST	LIMIT	S ARE	USED	TΟ	ESTAB	3LISH	INCOMI	NG	INSPE	CTIO	N AC	CEPTA	ANCE/	REJEC.	ΓION
CRITER	ΙA,	CORRE	ELATION	I OF	TEST	EQU	IPMENT	WITH	KNO	WLES	IS A	LS0	REQU	IRED	FOR	
ELIMIN	ATIC	N OF	EQUIPM	1ENT	AND	TEST	METHO	) VARI	ATI	ON						

CORRELATION OF TEST EQUIPMENT WITH KNO ON OF EQUIPMENT AND TEST METHOD VARIATI	АВ	11-29-05	
		CK. BY	DATE
RECEIVER	HC-23767-000	GJP	12-5-05
NECETVEN	110 231 01 000	APP. BY	DATE
PERFORMANCE SPECIFICATION	SHT 2.1	GJP	12-5-05

DR. BY